

Notice of References Cited

Application/Control No.

09/711,908

Applicant(s)/Patent Under
Reexamination
KOIDE ET AL.

Examiner

Wai-Sing Louie

Art Unit

2814

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
	A	US-6191436	02-2001	Shibata et al.	257	91
	B	US-6008539	12-1999	Shibata et al.	257	745
	C	US-5557115	09-1996	Shakuda	257	81
	D	US-				
	E	US-				
	F	US-				
	G	US-				
	H	US-				
	I	US-				
	J	US-				
	K	US-				
	L	US-				
	M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number	Date	Country	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY				
	N						
	O						
	P						
	Q						
	R						
	S						
	T						

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Preparation and optical properties of Ga1-xInxN thin films" by Osamura et al. PACS number 68.50, 78.65, 63.20D (1/15/1975)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.